Search Notes						
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/708,876	ZHOU ET AL.
Examiner	Art Unit
Rita Leykin	2837

						
	SEARCHED					
Class	Subclass	Date	Examiner			
318	439	1/20/2006	R.L.			
	434					
	138					
	254					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPAT, DERWENT, EPO, JPO USPGPUB	1/20/2006	R.L.	